Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/637,194	GRYSKA ET AL.	
Examiner	Art Unit	
Erin M. File	2611	

SEARCHED					
Class	Subclass	Date	Examiner		
375	140	11/7/2006	EMF		
375	147	11/7/2006	EMF		
375	148	11/7/2006	EMF		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST US PAT, USPGPUB, EPO, JPO DERWENT, IBM (text search only—see search history printout)	11/7/2006	EMF		
PALM INVENTORSHIP	11/7/2006	EMF		
PLUS Search	11/7/2006	EMF		
		9: 9		